

Search Notes

Application/Control No.

10/554,263

Examiner

David E. Bochna

Applicant(s)/Patent under
Reexamination

KIM, SUKYOON

Art Unit

3679

SEARCHED

Class	Subclass	Date	Examiner
285	307	1/7/2007	DB
	322		
	323		
	332.1		
	255		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR